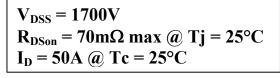
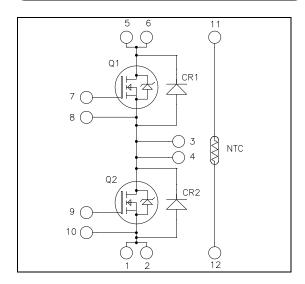


Phase leg SiC MOSFET Power Module





Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

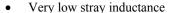
Features

• SiC Power MOSFET

- High speed switching
- Low R_{DS(on)}
- Ultra low loss

• SiC Schottky Diode

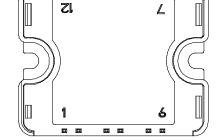
- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF



- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant



Pins 1/2; 3/4; 5/6 must be shorted together

All ratings @ $T_i = 25$ °C unless otherwise specified

Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1700	V
т	Continuous Drain Current	$T_c = 25^{\circ}C$	50	
I_{D}	Continuous Diani Current	$T_c = 80$ °C	37	Α
I_{DM}	Pulsed Drain current		100	
V_{GS}	Gate - Source Voltage		-10/25	V
V_{GSOP}	Gate - Source Voltage ; recommended operation values		-5/20	V
R_{DSon}	Drain - Source ON Resistance		70	mΩ
P_{D}	Power Dissipation	$T_c = 25^{\circ}C$	350	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions			Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$, $V_{DS} = 1700V$				100	μΑ
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		45	70	
$R_{DS(on)}$		$I_D = 50A$	$T_{j} = 150^{\circ}C$		90		mΩ
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 18mA$		2	2.4	4	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				600	nA

Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$			3672		
C_{oss}	Output Capacitance	$V_{DS} = 1000V$			171		pF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz			7		
Q_{g}	Total gate Charge	$V_{GS} = -5/+20V$			190		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 900V$			37		nC
Q_{gd}	Gate – Drain Charge	$I_D = 50A$			70		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$			105		
$T_{\rm r}$	Rise Time	$V_{GS} = -3/+20V$ $V_{Bus} = 900V$ $I_{D} = 50A$ $R_{Gext} = 20\Omega$			75		ns
$T_{d(off)}$	Turn-off Delay Time				210		
T_{f}	Fall Time				55		
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $-V_{Bus} = 900V$ $I_D = 50A$ $R_{Gext} = 20\Omega$	$T_j = 150$ °C		2.2		m I
E_{off}	Turn off Energy		$T_j = 150^{\circ}C$		1.5		mJ
R_{Gint}	Internal gate resistance				1.3		Ω
R_{thJC}	Junction to Case Thermal Resistan	ce				0.36	°C/W

Body diode ratings and characteristics (per SiC MOSFET) Symbol Characteristic Test Conditions

Symbol	Characteristic	Test Conditions		Mın	Тур	Max	Unit
V	Diode Forward Voltage	$V_{GS} = -5V$	$T_j = 25$ °C		4.1		V
V_{SD}		$I_{SD} = 25A$	$T_j = 150$ °C		3.6		V
t _{rr}	Reverse Recovery Time	$I_{SD} = 50A \; ; \; V_{GS} = -5V \ V_{R} = 900V \; ; \; di_{F}/dt = 1400A/\mu s$			70		ns
Q_{rr}	Reverse Recovery Charge				530		nC
I_{rr}	Reverse Recovery Current				14		A



SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					1700	V
T	December Leader to Comment	$V_p=1700V$	$T_j = 25$ °C		20	100	^
I_{RRM}	Reverse Leakage Current		$T_{j} = 175^{\circ}C$		100	400	μA
I_F	DC Forward Current		Tc = 125°C		25		A
V_{F}	Diode Forward Voltage	$I_{\rm F} = 25 A$	$T_i = 25$ °C		1.8 2	2	V
V F	Diode Forward Voltage	$T_i = 175$ °C			3.2	4	v
Qc	Total Capacitive Charge	$I_F = 25A, V_R = 1700V$ di/dt = $400A/\mu s$			170		nC
С	Total Capacitance	$f = 1 MHz, V_R = 200 V$			200		pF
		$f = 1MHz, V_R =$	400V		140		þΓ
R_{thJC}	Junction to Case Thermal Resistance					0.48	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Sj	ymbol	Characteristic		Min	Typ	Max	Unit
	R ₂₅	Resistance @ 25°C			50		kΩ
Δl	R_{25}/R_{25}				5		%
	B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		K
1	ΔΒ/Β		T _C =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

$$R_T: \text{ Thermistor value at T}$$

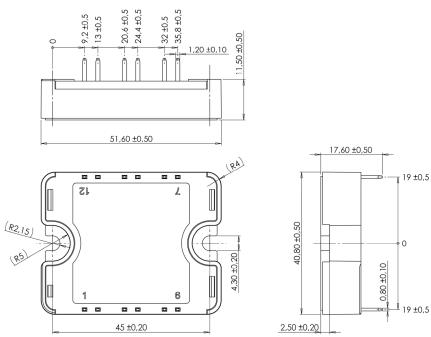
Thermal and package characteristics

Symbol	Characteristic	Min	Max	Unit		
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz					V
Т	Operating junction temperature range SiC MOSFET		SFET	-40	150	
T_{J}	Operating junction temperature range	SiC di	ode	-40	175	
T_{JOP}	Recommended junction temperature under switching conditions				T _J max -25	°C
T_{STG}	Storage Temperature Range				125	
$T_{\rm C}$	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				80	g

3 - 7

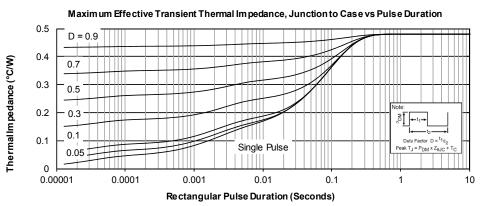


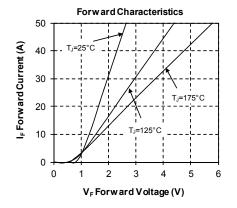
Package outline (dimensions in mm)

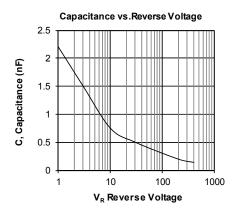


See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

Typical SiC diode Performance Curve

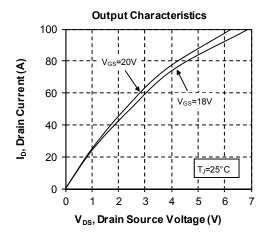


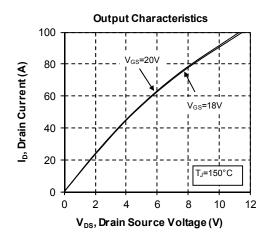


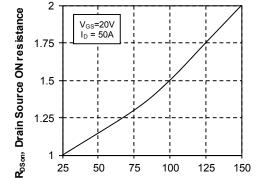




Typical SiC MOSFET Performance Curve







1.25

25

Normalized $R_{DS(on)}$ vs. Temperature

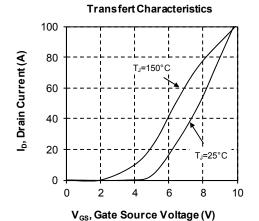
T_J, Junction Temperature (°C)

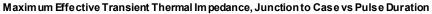
100

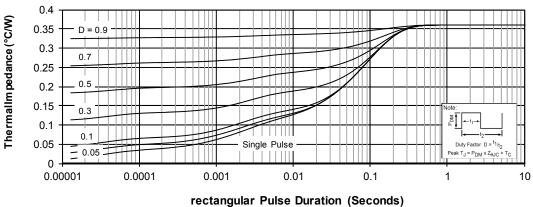
125

150

75



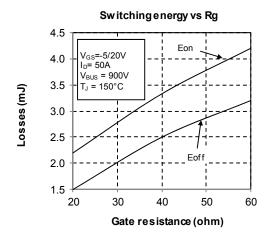




5 - 7

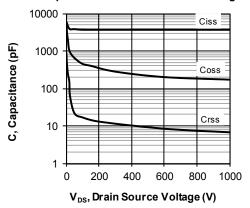


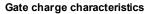
Power Matters.™



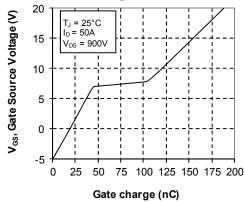
Switching energy vs current 2.5 V_{GS} =-5/20V R_G =20 Ω Eon 2.0 V_{BUS}= 900V T_J = 150°C Losses (mJ) 1.5 1.0 Eoff 0.5 0.0 10 20 30 40 50

Capacitance vs Drain to Source Voltage

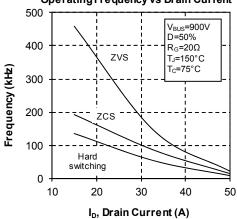




Current (A)



Operating Frequency vs Drain Current



DISCLAIMER

The information contained in the document (unless it is publicly available on the Web without access restrictions) is PROPRIETARY AND CONFIDENTIAL information of Microsemi and cannot be copied, published, uploaded, posted, transmitted, distributed or disclosed or used without the express duly signed written consent of Microsemi. If the recipient of this document has entered into a disclosure agreement with Microsemi, then the terms of such Agreement will also apply. This document and the information contained herein may not be modified, by any person other than authorized personnel of Microsemi. No license under any patent, copyright, trade secret or other intellectual property right is granted to or conferred upon you by disclosure or delivery of the information, either expressly, by implication, inducement, estoppels or otherwise. Any license under such intellectual property rights must be approved by Microsemi in writing signed by an officer of Microsemi.

Microsemi reserves the right to change the configuration, functionality and performance of its products at anytime without any notice. This product has been subject to limited testing and should not be used in conjunction with life-support or other mission-critical equipment or applications. Microsemi assumes no liability whatsoever, and Microsemi disclaims any express or implied warranty, relating to sale and/or use of Microsemi products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright or other intellectual property right. Any performance specifications believed to be reliable but are not verified and customer or user must conduct and complete all performance and other testing of this product as well as any user or customers final application. User or customer shall not rely on any data and performance specifications or parameters provided by Microsemi. It is the customer's and user's responsibility to independently determine suitability of any Microsemi product and to test and verify the same. The information contained herein is provided "AS IS, WHERE IS" and with all faults, and the entire risk associated with such information is entirely with the User. Microsemi specifically disclaims any liability of any kind including for consequential, incidental and punitive damages as well as lost profit. The product is subject to other terms and conditions which can be located on the web at http://www.microsemi.com/legal/tnc.asp

Life Support Application

Seller's Products are not designed, intended, or authorized for use as components in systems intended for space, aviation, surgical implant into the body, in other applications intended to support or sustain life, or for any other application in which the failure of the Seller's Product could create a situation where personal injury, death or property damage or loss may occur (collectively "Life Support Applications").

Buyer agrees not to use Products in any Life Support Applications and to the extent it does it shall conduct extensive testing of the Product in such applications and further agrees to indemnify and hold Seller, and its officers, employees, subsidiaries, affiliates, agents, sales representatives and distributors harmless against all claims, costs, damages and expenses, and attorneys' fees and costs arising, directly or directly, out of any claims of personal injury, death, damage or otherwise associated with the use of the goods in Life Support Applications, even if such claim includes allegations that Seller was negligent regarding the design or manufacture of the goods.

Buyer must notify Seller in writing before using Seller's Products in Life Support Applications. Seller will study with Buyer alternative solutions to meet Buyer application specification based on Sellers sales conditions applicable for the new proposed specific part.